

Notice of References Cited	Application/Control No. 10/781,470		Applicant(s)/Patent Under Reexamination SHIBUTANI, ATSUSHI	
	Examiner Yogesh K. Aggarwal		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0201741	10-2004	Ban, Shinichi	348/231.3
*	B	US-6,987,535	01-2006	Matsugu et al.	348/239
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

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